Notice of References Cited Application/Control No. 10/622,663 Applicant(s)/Patent Under Reexamination AGRAWAL, AVNEESH Examiner Betsy L. Deppe 2637 Applicant(s)/Patent Under Reexamination AGRAWAL, AVNEESH Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | Α | US-2002/0196876 A1 | 12-2002 | Takada, Masatoshi | 375/346 |
| * | В | US-4,470,138 | 09-1984 | Gutleber, Frank S. | 370/342 |
| * | O | US-5,537,434 | 07-1996 | Persson et al. | ·375/134 |
| * | D | US-5,548,582 | 08-1996 | Brajal et al. | 370/206 |
| * | Ε | US-6,504,837 B1 | 01-2003 | Menzel, Christian | 370/351 |
| * | F | US-6,549,784 B1 | 04-2003 | Kostic et al. | 455/501 |
| * | G | US-6,570,864 B1 | 05-2003 | Kim et al. | 370/342 |
| * | Н | US-6,570,909 B1 | 05-2003 | Kansakoski et al. | 375/148 |
| * | ı | US-6,826,409 B2 | 11-2004 | Kostic et al. | 455/501 |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | Ν | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | a | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | v | |
| | w | |
| | × | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.